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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
09/483,737	01/14/2000	Hansjorg Reichert	GR-97-P-1903	8769
75	90 06/27/2003			
Lerner And Greenberg PA		EXAMINER		
P O Box 2480 Hollywood, FL	33022-2480		SEFER, AHMED N	
			ART UNIT	PAPER NUMBER
			2826	
			DATE MAILED: 06/27/2003	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	_	Application No.	Applicant(s)	11		
Office Action Summary		09/483,737	REICHERT ET AL.	ď		
		Examiner	Art Unit			
		A. Sefer	2826			
Period fo	The MAILING DATE of this communication app or Reply	ears on the cover sheet with the c	correspondence address			
THE I - External after - If the - If NC - Failu - Any reame	ORTENED STATUTORY PERIOD FOR REPLY MAILING DATE OF THIS COMMUNICATION. nsions of time may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. e period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period were to reply within the set or extended period for reply will, by statute, reply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be ting within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).			
Status	Decreasive to communication/s) filed an 24 A					
1)⊠ 2a)□	Responsive to communication(s) filed on 21 A					
<i>'</i> =	·	is action is non-final.				
3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.						
Dispositi	ion of Claims					
4)⊠	Claim(s) 1-10 and 15 is/are pending in the app	olication.				
	4a) Of the above claim(s) 1-10 is/are withdrawn	from consideration.				
5)	Claim(s) is/are allowed.					
6)⊠	Claim(s) <u>15</u> is/are rejected.					
	Claim(s) is/are objected to.	$\mathcal{N}$				
-	Claim(s) are subject to restriction and/or	r election requirement.	V J. H.VA"I			
	ion Papers The appeignation is objected to by the Everynope	SUPERVISONY :	PATELLY STATER			
·	The specification is objected to by the Examiner The drawing(s) filed on is/are: a)□ accep		Y Classifi - 2000			
10)	Applicant may not request that any objection to the	•				
11) 🗆 -	The proposed drawing correction filed on					
,	If approved, corrected drawings are required in rep		2700 by 1110 1276111111011			
12)	The oath or declaration is objected to by the Exa					
Priority u	ınder 35 U.S.C. §§ 119 and 120					
	Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a	)-(d) or (f).			
a)[	☐ All b)☐ Some * c)☐ None of:		, , , , ,			
·	1. Certified copies of the priority documents	s have been received.				
	2. Certified copies of the priority documents	s have been received in Applicati	on No			
* S	3. Copies of the certified copies of the prior application from the International Bur See the attached detailed Office action for a list of the control of t	eau (PCT Rule 17.2(a)).	_			
14) <u></u> □ A	Acknowledgment is made of a claim for domestic	priority under 35 U.S.C. § 119(e	e) (to a provisional application	າ).		
	)  The translation of the foreign language protection  Acknowledgment is made of a claim for domesti					
Attachmen	t(s)					
2) Notic	e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO-1449) Paper No(s)	5) Notice of Informal f	r (PTO-413) Paper No(s) Patent Application (PTO-152)			
S. Patent and Tr	rademark Office					

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#### **DETAILED ACTION**

#### Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114 was filed in this application after a decision by the Board of Patent Appeals and Interferences, but before the filing of a Notice of Appeal to the Court of Appeals for the Federal Circuit or the commencement of a civil action. Since this application is eligible for continued examination under 37 CFR 1.114 and the fee set forth in 37 CFR 1.17(e) has been timely paid, the appeal has been withdrawn pursuant to 37 CFR 1.114 and prosecution in this application has been reopened pursuant to 37 CFR 1.114. Applicant's submission filed on 4/21/03 has been entered and claim 17 has been deleted.

### Response to Arguments

- 2. Applicant's arguments filed on 4/21/03 have been fully considered but they are not persuasive.
- 3. Applicant contends that the references of record do not teach the device structure as recited in claims 15 and 17. Specifically, Applicant argues that Yamagishi et al do not disclose a direct connection of a semiconductor body with a substrate over a thin gold-tin solder layer but merely disclose a device structure without a brazing material between the chip 4 and the substrate 1.
- 4. In response, Examiner would like to point out that claim 15 recites "a semiconductor chip secured to said substrate by one of alloying and brazing using said solder" without any reference to <u>a direct connection</u>.

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5. Applicant argues that the tin content 12-20% of the range 12-37% disclosed by Komata et al does not produce a hypereutectic gold-tin alloy – Applicant seems to be silent in regards to the remainder (20-37%) of the of the tin content.

- 6. Examiner fully agrees that the tin content 12-20% of the range 12-37% disclosed by Komata et al does not produce a hypereutectic gold-tin alloy. Examiner also recognizes that a prima facie case of obviousness typically exists when the ranges of a claimed composition overlap the ranges disclosed in the prior art. E.g., In re Geisler, 116 F.3d 1465, 1469, 43 USPQ2d 1362, 1365 (Fed. Cir. 1997).
- 7. Examiner acknowledges that the instant application has a filing date of 6/24/1998 and that Ivey et al US Patent No. 6,245,208 is not available as a prior art.

## Claim Rejections - 35 USC § 103

- 8. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 9. Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yamagishi et al. (JP 6-291239) in view of Komata et al (JP 2-15897) and Bacon et al. US Patent No. 5,234,153.

Yamagishi et al disclose in fig. 1c a solder containing at least two components with at least two constituents including a first constituent containing a precious metal and a second constituent being consumed during a soldering operation by one of reacting and being dissolved in material which are to be joined; a substrate 1; and a semiconductor chip 4 secured to

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said substrate by one of alloying and brazing using said solder, but do not teach a hypereutectic composition of Au-Sn with a thickness.

Komata et al a precious metal and tin solder 13 and said solder has a hypereutectic concentration containing gold-tin (AuSn) with a hypereutectic Sn concentration and containing a gold-tin compound (AuSn) having a composition, which falls within the range recited in the claim.

Bacon et al. teach (see col. 1 lines 50-63 and claim 7) the advantage of using a thin gold-tin compound solder.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to replace the Au-Sn eutectic alloy of Yamagishi et al with a hypereutectic Sn concentration of Komata et al, since that would prevent deformation thereby enhancing the mechanical strength of a semiconductor chip connection to a substrate. It would have been obvious to form a layer with a thickness of 1  $\mu$ m to 2  $\mu$ m, since that would provide a better thermal conductance.

10. Claim 15 is rejected under 35 U.S.C. 103(a) as being unpatentable over Yamagishi et al. (JP 6-291239) in view of Ishii (JP 6-326210) and Bacon et al. US Patent No. 5,234,153.

Yamagishi et al disclose in fig. 1c a solder containing at least two components with at least two constituents including a first constituent containing a precious metal and a second constituent being consumed during a soldering operation by one of reacting and being dissolved in material which are to be joined; a substrate 1; and a semiconductor chip 4 secured to said substrate by one of alloying and brazing using said solder, but do not teach a hypereutectic composition of Au-Sn with a thickness.

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Ishii discloses (see fig. 2 and attached machine translated version) a semiconductor chip 1 secured to a substrate 40 by gold and tin solder 8 and said solder has a hypereutectic concentration containing gold-tin (AuSn) with a hypereutectic Sn concentration and containing a gold-tin compound (AuSn) having a composition which falls within the range recited in the claim.

Bacon et al. teach (see col. 1 lines 50-63 and claim 7) the advantage of using a thin gold-tin compound solder.

Therefore, it would have been obvious to one skilled in the art at the time the invention was made to replace the Au-Sn eutectic alloy of Yamagishi et al with a hypereutectic Sn concentration of Ishii, since that would prevent deformation thereby enhancing the mechanical strength of a semiconductor chip connection to a substrate. It would have been obvious to form a layer with a thickness of 1  $\mu$ m to 2  $\mu$ m, since that would provide a better thermal conductance.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to A. Sefer whose telephone number is (703) 605-1227.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (703) 308-6601.

ANS June 19, 2003